

CBR02C139C1GAC

CBR-SMD RF COG, Ceramic, 1.3 pF, +/-0.25 pF, 100 VDC, COG, SMD, Fixed, RF, Ultra High Q, Low ESR, Class I, 0201



Click here for the 3D model.

| Dimensions | |
|------------|------------------|
| Chip Size | 0201 |
| L | 0.6mm +/-0.03mm |
| W | 0.3mm +/-0.03mm |
| Т | 0.3mm +/-0.03mm |
| В | 0.15mm +/-0.05mm |

| Packaging Specifications | | |
|--------------------------|--------------------------|--|
| Packaging | T&R, 180mm, Plastic Tape | |
| Packaging Quantity | 15000 | |

| CBR-SMD RF COG |
|--|
| SMD Chip |
| SMD, Fixed, RF, Ultra High Q, Low ESR, Class I |
| Ultra High Q, Low ESR, Class I |
| Yes |
| Tin |
| No |
| No |
| 0.3 mg |
| Solder Wave or Solder Reflow. |
| 78 Weeks |
| 1 |
| |

| Specifications | |
|--|---------------------------|
| Capacitance | 1.3 pF |
| Capacitance Tolerance | +/-0.25 pF |
| Voltage DC | 100 VDC |
| Dielectric Withstanding Voltage | 250 VDC |
| Temperature Range | -55/+125°C |
| Temperature Coefficient | COG |
| Capacitance Change with Reference to +25°C and 0 VDC Applied (TCC) | 30 ppm/C, 1MHz 1.0Vrms |
| Dissipation Factor | 0.2%1MHz 1.0Vrms |
| Aging Rate | 0% Loss/Decade Hour |
| Insulation Resistance | 10 GOhms |
| Quality Factor | 426 |

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